

Search Notes

Application/Control No.

10/672,715

Examiner

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Applicant(s)/Patent under
Reexamination

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Art Unit

2825

SEARCHED

Class	Subclass	Date	Examiner
716	12	9/7/2005	JSL
716	1	9/7/2005	JSL
716	7	9/7/2005	JSL
716	8	9/7/2005	JSL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST [USPAT;US- PGPUB;EPO;JPO;DERWENT;IBM_T DB]	9/7/2005	JSL
EAST [USPAT;US- PGPUB;EPO;JPO;DERWENT;IBM_T DB]	9/8/2005	JSL
IEEE	9/8/2005	JSL